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Application Number	10/662,979
Filing Date	September 15, 2003
First Named Inventor	Charles W. Extrand
Art Unit	2262
Examiner Name	Robert W. Hodge
Attorney Docket Number	2267.841US03

Sheet 1 of 7

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		Number-Kind Code ² (if known)		
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RWH		US-6,660,363 B1	12/09/2003	Wilhelm Barthlott
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Sheet	2	of	7	Attorney Docket Number	2267.841US03
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EXAMINER INITIAL*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	T ⁶
		Country Code ³ Number ⁴ Kind Code ⁵ (if known)			
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EXAMINER SIGNATURE	<i>Robert H. Hays</i>			DATE CONSIDERED	2-17-05
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